Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/506,602	MIHAN ET AL.	
Examiner	Art Unit	

In Suk Bullock

SEARCHED				
Class	Subclass	Date	Examiner	
585	511-513, 521-523, 525, 527, 53	2/16/2006	IB	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				

SEARCH N (INCLUDING SEAR)
	DATE	EXMR
EAST (see search printout)	2/16/2006	IB
, Inventor searched in PALM	2/16/2006	IB
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